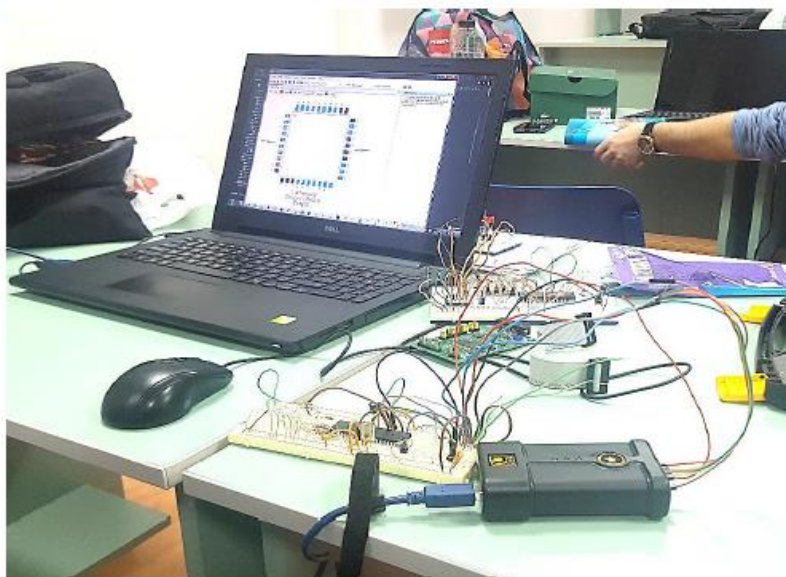
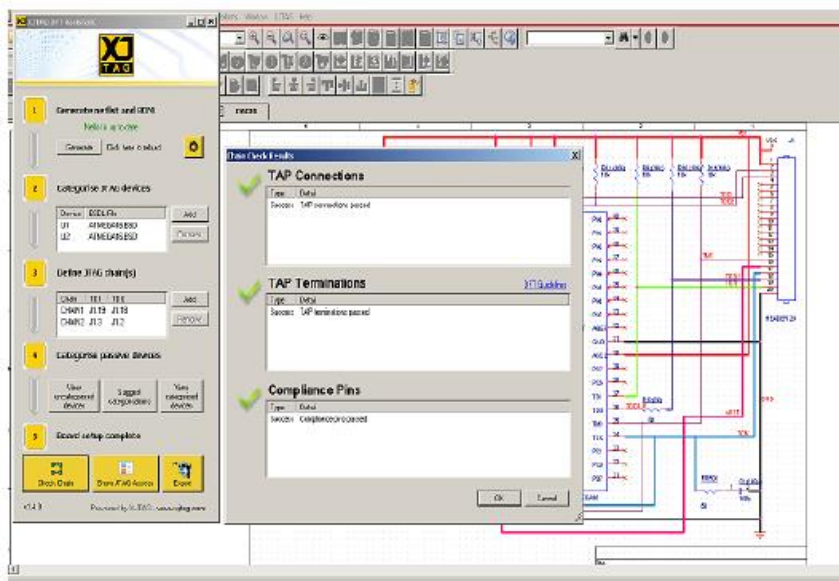


## Topology elements of electronic systems

(the former Design for Boundary Scan lecture)



Coordinators: **Raul Ionel** (raul.ionel@upt.ro) & **Anca Dărăbuț** (anca.darabut@upt.ro).  
Supported by [Alfa Test](#) and [XJTAG](#).

- ➡ The “Topology elements of electronic systems” lecture (the former “Design for Boundary Scan” lecture) proposes the study and implementation of the complete populated electronic board-level product development chain, starting from the specifications study, design phase and ending with the physical prototype testing and validation.
  - ➡ Our students will use specific state-of-the-art hardware & software technology and focus on activities such as circuit design for testability, circuit validation, circuit implementation and test-related software development. Finally, a comprehensive non-invasive quality evaluation of the student built electronic board prototype attests the project success.
  - ➡ This subject has direct applicability in the electronics industry, specifically in fields such as Telecommunications, Automotive or Consumer electronics.
- 😊 Form of evaluation – Exam, contribution during lectures, laboratory tests, laboratory work, 4 credits.

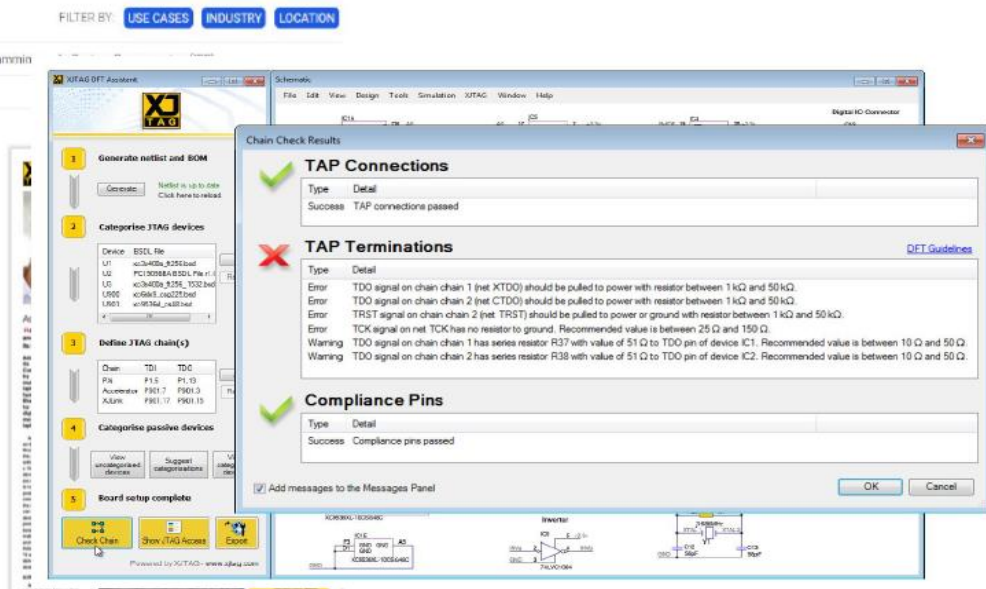
1. P. Kenneth, The Boundary-Scan Handbook, ISBN 978-1-4757-2142-3, DOI 10.1007/978-1-4757-2142-3, Springer US, 1992.
2. B. H. van den Eijnden, F. P. de Jong, Boundary-Scan Test - A Practical Approach, ISBN: 978-1-4613-6371-2, DOI 10.1007/978-1-4615-3132-6, Springer US, 1993.
3. Ben Bennets, Lecture Notes, Boundary Scan Tutorial, [http://fiona.dmcs.pl/~cmaj/JTAG/boundaryscan\\_tutorial.pdf](http://fiona.dmcs.pl/~cmaj/JTAG/boundaryscan_tutorial.pdf)
4. <https://www.xjtag.com/about-jtag/> 5. XJTAG Tutorials and Case Studies, available on [xjtag.com](http://www.xjtag.com)

## Diploma Work - Boundary Scan Testing on Student Built PCB

### 90+ Case Studies

Here are some XJTAG case studies with world leading companies around the world.

3rd Party Integration Ball Grid Arrays (BGA) Circuit Visualisation Design for Test (DFT) Fast Test Development Fault Diagnosis High Density Circuit Boards High-Speed Flash Programming LabView Integration PCB Design Verification Production / Manufacturing Test Prototype Debug Test Coverage Analysis

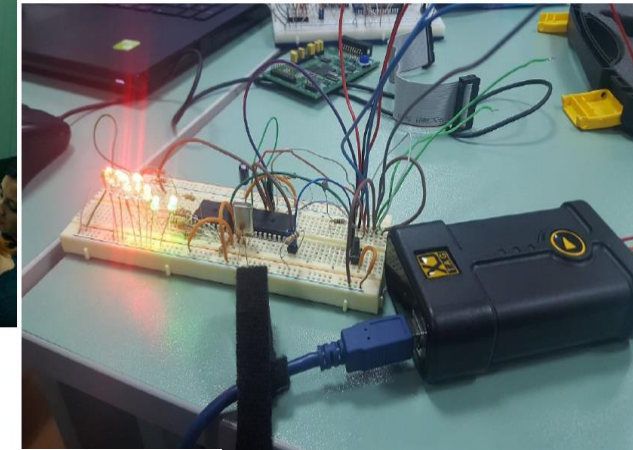
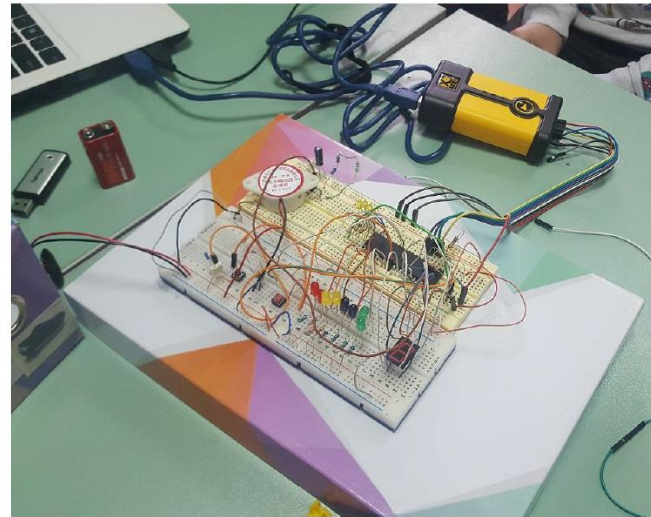




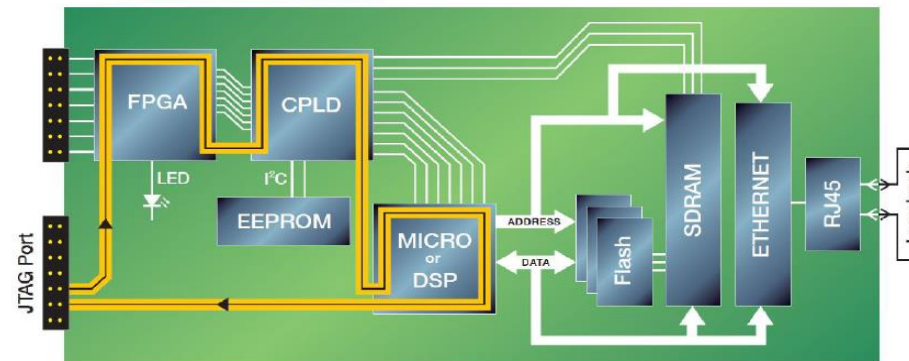
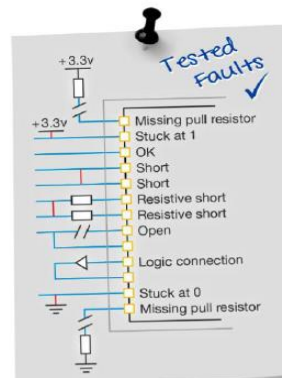
# Topology elements of electronic systems

## Some images

### The work



### The flow



# Topology elements of electronic systems

## Where can you use this knowledge?

In industry



For extended information, please send your inquiry to [raul.ionel@upt.ro](mailto:raul.ionel@upt.ro)/[anca.darabut@upt.ro](mailto:anca.darabut@upt.ro), message subject **Optional Topic 9 info**.